









SN74AHC74Q-Q1

SGDS020D - FEBRUARY 2002 - REVISED FEBRUARY 2024

# SN74AHC74Q-Q1 Automotive Dual Positive-Edge-Triggered D-Type Flip-Flops With **Clear and Preset**

#### 1 Features

- AEC-Q100 qualified for automotive applications:
  - Device temperature grade 1: -40°C to +125°C
  - Device HBM ESD classification level 2
  - Device CDM ESD classification level C4B
- Available in wettable flank QFN package
- Operating range 2V to 5.5V V<sub>CC</sub>
- Latch-up performance exceeds 250mA per JESD 17

# 2 Applications

- Convert a momentary switch to a toggle switch
- Hold a signal during controller reset
- Divide a clock signal by two

### 3 Description

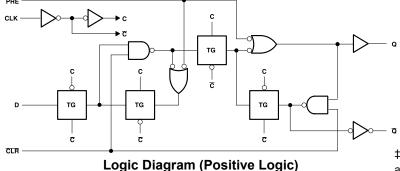
The SN74AHC74Q-Q1 dual positive-edge-triggered device is a D-type flip-flop.

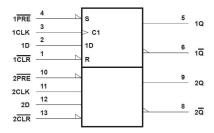
A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

#### **Package Information**

| PART NUMBER   | PACKAGE <sup>(1)</sup> | PACKAGE<br>SIZE <sup>(2)</sup> | BODY SIZE(3)   |
|---------------|------------------------|--------------------------------|----------------|
|               | BQA (WQFN, 14)         | 3mm × 2.5mm                    | 3mm × 2.5mm    |
| SN74AHC74Q-Q1 | D (SOIC, 14)           | 8.65mm × 6mm                   | 8.65mm × 3.9mm |
|               | PW (TSSOP, 14)         | 5mm × 6. mm                    | 5mm × 4.4mm    |

- For more information, see Section 11.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.





‡ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Logic Symbol‡



# **Table of Contents**

| 1 Features1  | 7.1 Overview   | 10 |
|--|--|----|
| 2 Applications1  | 7.2 Functional Block Diagram                         | 10 |
| 3 Description1   | 7.3 Feature Description                              |    |
| 4 Pin Configuration and Functions3                                   | 7.4 Device Functional Modes                          |    |
| 5 Specifications4  | 8 Application and Implementation                     | 14 |
| 5.1 Absolute Maximum Ratings4  | 8.1 Application Information                          | 14 |
| 5.2 ESD Ratings 4  | 8.2 Typical Application                              | 14 |
| 5.3 Recommended Operating Conditions4                                | 8.3 Power Supply Recommendations                     | 16 |
| 5.4 Thermal Information — SN74AHC74Q-Q15                             | 8.4 Layout   | 16 |
| 5.5 Electrical Characteristics5                                      | 9 Device and Documentation Support                   | 18 |
| 5.6 Timing Requirements — $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ | 9.1 Documentation Support                            | 18 |
| 5.7 Timing Requirements — $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}5$  | 9.2 Receiving Notification of Documentation Updates. | 18 |
| 5.8 Switching Characteristics, V <sub>CC</sub> = 3.3 V ± 0.3 V6      | 9.3 Support Resources                                | 18 |
| 5.9 Switching Characteristics, V <sub>CC</sub> = 5 V ± 0.5 V6        | 9.4 Trademarks                                       | 18 |
| 5.10 Noise Characteristics6  | 9.5 Electrostatic Discharge Caution                  | 18 |
| 5.11 Operating Characteristics7                                      | 9.6 Glossary   | 18 |
| 5.12 Typical Characteristics7  | 10 Revision History                                  |    |
| 6 Parameter Measurement Information9                                 | 11 Mechanical, Packaging, and Orderable              |    |
| 7 Detailed Description10   | Information  | 18 |
|  |  |    |



# **4 Pin Configuration and Functions**

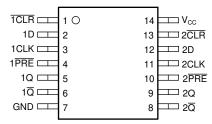


Figure 4-1. SN74AHC74Q-Q1 D or PW Package, 14-Pin SOIC or TSSOP (Top View)

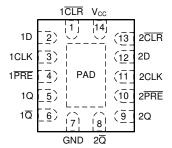


Figure 4-2. SN74AHC74Q-Q1 BQA Package, 14-Pin WQFN (Transparent Top View)

**Table 4-1. Pin Functions** 

| P                          | IN  | TYPE <sup>(1)</sup> | DESCRIPTION  |
|----------------------------|-----|---------------------|--|
| NAME                       | NO. | ITPE\''             | DESCRIPTION  |
| 1CLR                       | 1   | I                   | Asynchronous clear for channel 1, active low   |
| 1D                         | 2   | I                   | Data for channel 1   |
| 1CLK                       | 3   | I                   | Clock for channel 1, rising edge triggered   |
| 1PRE                       | 4   | I                   | Asynchronous preset for channel 1, active low  |
| 1Q                         | 5   | 0                   | Output for channel 1   |
| 1Q                         | 6   | 0                   | Inverted output for channel 1  |
| GND                        | 7   | G                   | Ground   |
| 2Q                         | 8   | 0                   | Inverted output for channel 2  |
| 2Q                         | 9   | 0                   | Output for channel 2   |
| 2PRE                       | 10  | I                   | Asynchronous preset for channel 2, active low  |
| 2CLK                       | 11  | I                   | Clock for channel 2, rising edge triggered   |
| 2D                         | 12  | I                   | Data for channel 2   |
| 2CLR                       | 13  | I                   | Asynchronous clear for channel 2, active low   |
| V <sub>CC</sub>            | 14  | Р                   | Positive supply  |
| Thermal Pad <sup>(2)</sup> |     | _                   | The thermal pad can be connected to GND or left floating. Do not connect to any other signal or supply |

<sup>(1)</sup> I = input, O = output, P = power, G = ground

<sup>(2)</sup> BQA package only



### **5 Specifications**

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

|                    |  | ·                                    | MIN  | MAX                   | UNIT |
|--------------------|--|--------------------------------------|------|-----------------------|------|
| V <sub>CC</sub>    | Supply voltage range                             |                                      | -0.5 | 7                     | V    |
| V <sub>I</sub> (2) | Input voltage range                              |                                      | -0.5 | 7                     | V    |
| V <sub>O</sub> (2) | Output voltage range                             |                                      | -0.5 | V <sub>CC</sub> + 0.5 | V    |
| I <sub>IK</sub>    | Input clamp current                              | (V <sub>1</sub> < 0)                 |      | -20                   | mA   |
| I <sub>OK</sub>    | Output clamp current                             | $(V_O < 0 \text{ or } V_O > V_{CC})$ |      | ±20                   | mA   |
| Io                 | Continuous output current                        | $(V_O = 0 \text{ to } V_{CC})$       |      | ±25                   | mA   |
|                    | Continuous current through V <sub>CC</sub> or GN | ID                                   |      | ±50                   | mA   |
| T <sub>stg</sub>   | Storage temperature range                        |                                      | -65  | 150                   | °C   |

<sup>(1)</sup> Operation outside the Absolute Maximum Rating may cause permanent device damage. Absolute Maximum Rating do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Condition. If used outside the Recommended Operating Condition but within the Absolute Maximum Rating, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 5.2 ESD Ratings

|                    |                         |  | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
|                    |                         | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±2000 |      |
| V <sub>(ESD)</sub> | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±1000 | V    |

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### **5.3 Recommended Operating Conditions**

|                                |  |                                 | MIN  | MAX             | UNIT |  |
|--------------------------------|--|---------------------------------|------|-----------------|------|--|
| V <sub>CC</sub>                | Supply voltage                         |                                 | 2    | 5.5             | V    |  |
|                                |  | V <sub>CC</sub> = 2 V           | 1.5  |                 |      |  |
| V <sub>IH</sub>                | High-level input voltage               | V <sub>CC</sub> = 3 V           | 2.1  |                 | V    |  |
|                                |  | V <sub>CC</sub> = 5.5 V         | 3.85 |                 |      |  |
|                                |  | V <sub>CC</sub> = 2 V           |      | 0.5             |      |  |
| V <sub>IL</sub>                | Low-level input voltage                | V <sub>CC</sub> = 3 V           |      | 0.9             | V    |  |
|                                |  | V <sub>CC</sub> = 5.5 V         |      | 1.65            |      |  |
| V <sub>I</sub> <sup>(1)</sup>  | Input voltage                          |                                 | 0    | 5.5             | V    |  |
| Vo                             | Output voltage                         |                                 | 0    | V <sub>CC</sub> | V    |  |
|                                |  | V <sub>CC</sub> = 2 V           |      | -50             | μA   |  |
| I <sub>OH</sub> <sup>(2)</sup> | High-level output current              | V <sub>CC</sub> = 3.3 V ± 0.3 V |      | -4              | m Λ  |  |
|                                |  | V <sub>CC</sub> = 5 V ± 0.5 V   |      | -8              | mA   |  |
|                                |  | V <sub>CC</sub> = 2 V           |      | 50              | μA   |  |
| I <sub>OL</sub> (2)            | Low-level output current               | V <sub>CC</sub> = 3.3 V ± 0.3 V |      | 4               | m Λ  |  |
|                                |  | V <sub>CC</sub> = 5 V ± 0.5 V   |      | 8               | mA   |  |
| 44/4                           | lament transmitting wine and fall mate | V <sub>CC</sub> = 3.3 V ± 0.3 V |      | 100             | A /  |  |
| Δt/Δν                          | Input transition rise or fall rate     | V <sub>CC</sub> = 5 V ± 0.5 V   |      | 20              | ns/V |  |
| T <sub>A</sub>                 | Operating free-air temperature         |                                 | -40  | 125             | °C   |  |

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND for proper device operation. Refer to the TI application report, *Implications* of Slow or Floating CMOS Inputs, literature number SCBA004.

Product Folder Links: SN74AHC74Q-Q1

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

Recommended current values provided to maintain appropriate output state as per the relevant output voltage specification (Vol. for I<sub>OL</sub>, V<sub>OH</sub> for I<sub>OH</sub>). See *Electrical Characteristics* table for details.

### 5.4 Thermal Information — SN74AHC74Q-Q1

|                 | THERMAL METRIC <sup>(1)</sup> BQA (WQI |         | D (SOIC) | PW (TSSOP) | UNIT  |
|-----------------|--|---------|----------|------------|-------|
|                 | THERMAL METRIC                         | 14 PINS | 14 PINS  | 14 PINS    | Olvii |
| R <sub>0J</sub> | Junction-to-ambient thermal resistance | 88.3    | 124.6    | 147.7      | °C/W  |

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

### 5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER       | TEST CONDITIONS                         | V               | T,   | <sub>Δ</sub> = 25 °C |      | –40 to +125 °C |     | UNIT |
|-----------------|---|-----------------|------|----------------------|------|----------------|-----|------|
| PARAMETER       | TEST CONDITIONS                         | V <sub>cc</sub> | MIN  | TYP                  | MAX  | MIN            | MAX | UNII |
|                 |   | 2 V             | 1.9  | 2                    |      | 1.9            |     |      |
| V <sub>OH</sub> | I <sub>OH</sub> = -50 μA                | 3 V             | 2.9  | 3                    |      | 2.9            |     |      |
|                 |   | 4.5 V           | 4.4  | 4.5                  |      | 4.4            |     | V    |
|                 | I <sub>OH</sub> = -4 mA                 | 3 V             | 2.58 |                      |      | 2.48           |     |      |
|                 | I <sub>OH</sub> = -8 mA                 | 4.5 V           | 3.94 |                      |      | 3.8            |     |      |
|                 |   | 2 V             |      |                      | 0.1  |                | 0.1 |      |
|                 | I <sub>OL</sub> = 50 μA                 | 3 V             |      |                      | 0.1  |                | 0.1 |      |
| V <sub>OL</sub> |   | 4.5 V           |      |                      | 0.1  |                | 0.1 | V    |
|                 | I <sub>OL</sub> = 4 mA                  | 3 V             |      |                      | 0.36 |                | 0.5 |      |
|                 | I <sub>OL</sub> = 8 mA                  | 4.5 V           |      |                      | 0.36 |                | 0.5 |      |
| I <sub>1</sub>  | V <sub>I</sub> = 5.5 V or GND           | 0 V to 5.5 V    |      |                      | ±0.1 |                | ±1  | μA   |
| Icc             | $V_1 = V_{CC}$ or $I_0 = 0$             | 5.5 V           |      |                      | 2    |                | 20  | μΑ   |
| Ci              | V <sub>I</sub> = V <sub>CC</sub> or GND | 5 V             |      | 2                    | 10   |                | 10  | pF   |

# 5.6 Timing Requirements — $V_{CC}$ = 3.3 V ± 0.3 V

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER       | DESCRIPTION                | CONDITION           | T <sub>A</sub> = 25°C |     | -40°C to 125°C |     | UNIT |
|-----------------|----------------------------|---------------------|-----------------------|-----|----------------|-----|------|
| FARAINETER      | DESCRIPTION                | CONDITION           | MIN                   | MAX | MIN            | MAX | ONII |
| 4               | Pulse duration             | PRE or CLR LOW      | 6                     |     | 7              |     | ns   |
| L <sub>W</sub>  | Fuise duration             | CLK                 | 6                     |     | 7              |     | ns   |
| +               | Setup time before CLK↑     | Data                | 6                     |     | 7              |     | ns   |
| L <sub>Su</sub> | Setup time before CLN      | PRE or CLR Inactive | 5                     |     | 5              |     | ns   |
| t <sub>h</sub>  | Hold time, data after CLK↑ |                     | 0.5                   |     | 0.5            |     | ns   |

### 5.7 Timing Requirements — $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER       | DESCRIPTION            | CONDITION           | T <sub>A</sub> = 25°C |     | -40°C to 125°C |     | UNIT |
|-----------------|------------------------|---------------------|-----------------------|-----|----------------|-----|------|
| PARAMETER       |                        | CONDITION           | MIN                   | MAX | MIN            | MAX | UNII |
| 4               | Pulse duration         | PRE or CLR LOW      | 5                     |     | 5              |     | ns   |
| \w              |                        | CLK                 | 5                     |     | 5              |     | ns   |
|                 | Octor that before OLKA | Data                | 5                     |     | 5              |     | ns   |
| L <sub>SU</sub> | Setup time before CLK↑ | PRE or CLR Inactive | 3                     |     | 3              |     | ns   |

Copyright © 2024 Texas Instruments Incorporated

Submit Document Feedback

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER      | DESCRIPTION | CONDITION                  | T <sub>A</sub> = 25 | 5°C | -40°C to 125°C |     | UNIT |    |
|----------------|-------------|----------------------------|---------------------|-----|----------------|-----|------|----|
|                | PARAWEIER   | DESCRIPTION                | CONDITION           | MAX | MIN            | MAX |      |    |
| t <sub>h</sub> |             | Hold time, data after CLK↑ |                     | 0.5 |                | 0.5 |      | ns |

# 5.8 Switching Characteristics, $V_{CC}$ = 3.3 V $\pm$ 0.3 V

over recommended operating free-air temperature range (see Section 6)

| PARAMETER        | FROM (INPUT) | TO (OUTPUT)                  | LOAD                   | Т   | <sub>A</sub> = 25°C |      | -40 to +125 °C |      | UNIT |
|------------------|--------------|------------------------------|------------------------|-----|---------------------|------|----------------|------|------|
| PARAMETER        | PROW (INPUT) | 10 (001701)                  | CAPACITANCE            | MIN | TYP                 | MAX  | MIN            | MAX  | UNIT |
| f <sub>max</sub> |              |                              | C <sub>L</sub> = 15 pF | 80  | 125                 |      | 70             |      | no   |
| max              |              |                              | C <sub>L</sub> = 50 pF | 50  | 75                  |      | 45             |      | ns   |
| t <sub>PLH</sub> | PRE or CLR   | Q or $\overline{\mathbb{Q}}$ | C <sub>1</sub> = 15 pF |     | 7.6                 | 12.3 | 1              | 14.5 | ns   |
| t <sub>PHL</sub> |              | QUIQ                         | CL = 13 pr             |     | 7.6                 | 12.3 | 1              | 14.5 | 115  |
| t <sub>PLH</sub> | CLK          | Q or $\overline{\mathbb{Q}}$ | C <sub>1</sub> = 15 pF |     | 6.7                 | 11.9 | 1              | 14   | no   |
| t <sub>PHL</sub> | CLK          | Q 01 Q   CL = 13 pr          | OL = 13 pr             |     | 6.7                 | 11.9 | 1              | 14   | ns   |
| t <sub>PLH</sub> | PRE or CLR   | Q or $\overline{\mathbb{Q}}$ | C <sub>1</sub> = 50 pF |     | 10.1                | 15.8 | 1              | 18   | ns   |
| t <sub>PHL</sub> | FIXE OF CER  | Q or Q                       | C <sub>L</sub> = 50 pr |     | 10.1                | 15.8 | 1              | 18   | 115  |
| t <sub>PLH</sub> | CLK          | Q or $\overline{\mathbb{Q}}$ | C <sub>L</sub> = 50 pF |     | 9.2                 | 15.4 | 1              | 17.5 | ns   |
| t <sub>PHL</sub> | OLK          | QUIQ                         | OL - 30 pr             |     | 9.2                 | 15.4 | 1              | 17.5 | 115  |

## 5.9 Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, (see Section 6)

| PARAMETER        | FROM (INPUT) | TO (OUTPUT)                  | LITPLIT) LOAD          |     | T <sub>A</sub> = 25°C |     |     | 25 °C | UNIT |
|------------------|--------------|------------------------------|------------------------|-----|-----------------------|-----|-----|-------|------|
| PARAMETER        | PROW (INPUT) | 10 (001701)                  | CAPACITANCE            | MIN | TYP                   | MAX | MIN | MAX   | UNIT |
| f                |              |                              | C <sub>L</sub> = 15 pF | 130 | 170                   |     | 110 |       | ns   |
| Imax             |              |                              | C <sub>L</sub> = 50 pF | 90  | 115                   |     | 75  |       | 115  |
| t <sub>PLH</sub> | PRE or CLR   | Q or $\overline{\mathbb{Q}}$ | C <sub>I</sub> = 15 pF |     | 4.8                   | 7.7 | 1   | 9     | no   |
| t <sub>PHL</sub> | PRE OI CLK   | Q or Q                       | OL = 15 pr             |     | 4.8                   | 7.7 | 1   | 9     | ns   |
| t <sub>PLH</sub> | CLK          | Q or Q                       | C <sub>L</sub> = 15 pF |     | 4.6                   | 7.3 | 1   | 8.5   | ns   |
| t <sub>PHL</sub> | CLK          |                              |                        |     | 4.6                   | 7.3 | 1   | 8.5   | 115  |
| t <sub>PLH</sub> | PRE or CLR   | Q or $\overline{\mathbb{Q}}$ | C = 50 pE              |     | 6.3                   | 9.7 | 1   | 11    | ns   |
| t <sub>PHL</sub> | FIXE OF CER  | QUIQ                         | C <sub>L</sub> = 50 pF |     | 6.3                   | 9.7 | 1   | 11    | 115  |
| t <sub>PLH</sub> | CLK          | Q or Q                       | C <sub>L</sub> = 50 pF |     | 6.1                   | 9.3 | 1   | 10.5  | ns   |
| t <sub>PHL</sub> | OLK          |                              |                        |     | 6.1                   | 9.3 | 1   | 10.5  |      |

#### **5.10 Noise Characteristics**

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}C^{(1)}$ 

|                    | PARAMETER                                     | MIN | TYP | MAX  | UNIT |
|--------------------|---|-----|-----|------|------|
| V <sub>OL(P)</sub> | Quiet output, maximum dynamic V <sub>OL</sub> |     |     | 0.8  | V    |
| V <sub>OL(V)</sub> | Quiet output, minimum dynamic V <sub>OL</sub> |     |     | -0.8 | V    |
| V <sub>OH(V)</sub> | Quiet output, minimum dynamic V <sub>OH</sub> | 4.7 |     |      | V    |
| V <sub>IH(D)</sub> | High-level dynamic input voltage              | 3.5 |     |      | V    |
| V <sub>IL(D)</sub> | Low-level dynamic input voltage               |     |     | 1.5  | V    |

(1) Characteristics are for surface-mount packages only.



### 5.11 Operating Characteristics

 $V_{CC}$  = 5 V,  $T_A$  = 25°C

| PARAMETER       |                               |          | TEST CONDITIONS | TYP | UNIT |
|-----------------|-------------------------------|----------|-----------------|-----|------|
| C <sub>pd</sub> | Power dissipation capacitance | No load, | f = 1 MHz       | 32  | pF   |

### **5.12 Typical Characteristics**

T<sub>A</sub> = 25°C (unless otherwise noted)

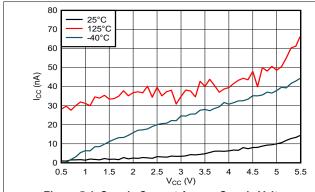


Figure 5-1. Supply Current Across Supply Voltage

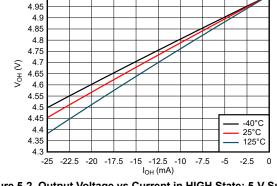


Figure 5-2. Output Voltage vs Current in HIGH State; 5-V Supply

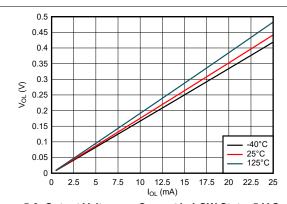


Figure 5-3. Output Voltage vs Current in LOW State; 5-V Supply

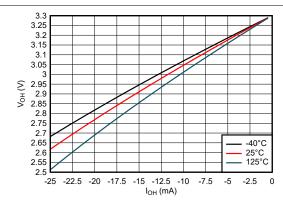


Figure 5-4. Output Voltage vs Current in HIGH State; 3.3-V Supply

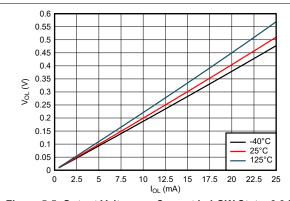


Figure 5-5. Output Voltage vs Current in LOW State; 3.3-V Supply

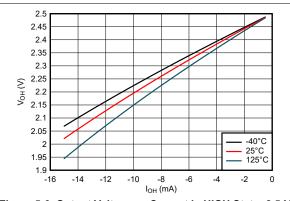
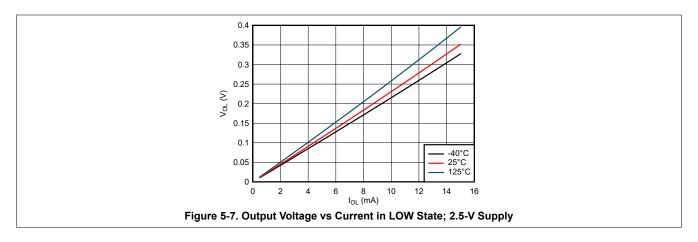


Figure 5-6. Output Voltage vs Current in HIGH State; 2.5-V Supply



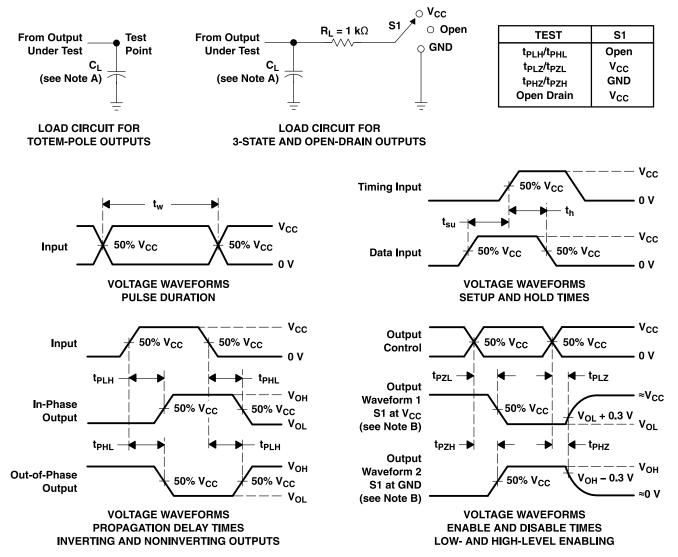
# **5.12 Typical Characteristics (continued)**

T<sub>A</sub> = 25°C (unless otherwise noted)





#### **6 Parameter Measurement Information**



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f \leq$  3 ns.  $t_f \leq$  3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 6-1. Load Circuit And Voltage Waveforms

### 7 Detailed Description

#### 7.1 Overview

The SN74AHC74Q-Q1 dual positive-edge-triggered devices are D-type flip-flops.

A low level at the preset  $(\overline{PRE})$  or clear  $(\overline{CLR})$  inputs sets or resets the outputs, regardless of the levels of the other inputs. When  $\overline{PRE}$  and  $\overline{CLR}$  are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

#### 7.2 Functional Block Diagram

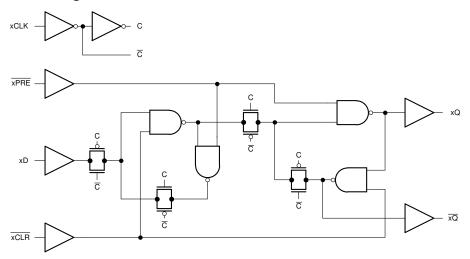


Figure 7-1. Logic Diagram (Positive Logic) for One Channel of SN74AHC74Q-Q1

#### 7.3 Feature Description

### 7.3.1 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs should be left disconnected.

#### 7.3.2 Latching Logic

This device includes latching logic circuitry. Latching circuits commonly include D-type latches and D-type flip-flops, but include all logic circuits that act as volatile memory.

When the device is powered on, the state of each latch is unknown. There is no default state for each latch at start-up.

The output state of each latching logic circuit only remains stable as long as power is applied to the device within the supply voltage range specified in the *Recommended Operating Conditions* table.

### 7.3.3 Standard CMOS Inputs

This device includes standard CMOS inputs. Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst

Submit Document Feedback

Copyright © 2024 Texas Instruments Incorporated

case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law  $(R = V \div I)$ .

Standard CMOS inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the *Recommended Operating Conditions* table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in *Implications of Slow or Floating CMOS Inputs*.

Do not leave standard CMOS inputs floating at any time during operation. Unused inputs must be terminated at  $V_{CC}$  or GND. If a system will not be actively driving an input at all times, then a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; a  $10\text{-k}\Omega$  resistor, however, is recommended and will typically meet all requirements.

#### 7.3.4 Wettable Flanks

This device includes wettable flanks for at least one package. See the *Features* section on the front page of the data sheet for which packages include this feature.

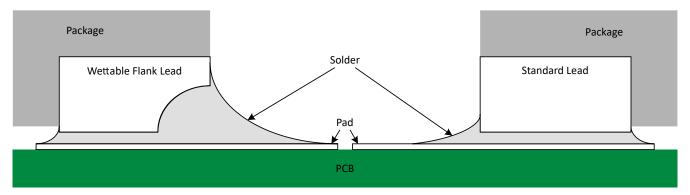


Figure 7-2. Simplified Cutaway View of Wettable-Flank QFN Package and Standard QFN Package After Soldering

Wettable flanks help improve side wetting after soldering, which makes QFN packages easier to inspect with automatic optical inspection (AOI). As shown in Figure 7-2, a wettable flank can be dimpled or step-cut to provide additional surface area for solder adhesion which assists in reliably creating a side fillet. See the mechanical drawing for additional details.

#### 7.3.5 Clamp Diode Structure

As Figure 7-3 shows, the outputs to this device have both positive and negative clamping diodes, and the inputs to this device have negative clamping diodes only.

#### **CAUTION**

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

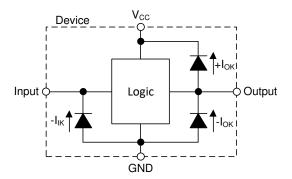


Figure 7-3. Electrical Placement of Clamping Diodes for Each Input and Output

#### 7.4 Device Functional Modes

Table 7-1 shows the function table for each input and output.

Table 7-1. Function Table (Each Flip-Flop)

|     | INP | OUT | PUTS |   |   |
|-----|-----|-----|------|---|---|
| PRE | CLR | CLK | D    | Q | Q |
| L   | Н   | Х   | Х    | Н | L |
| Н   | L   | X   | X    | L | Н |

Product Folder Links: SN74AHC74Q-Q1

Table 7-1. Function Table (Each Flip-Flop) (continued)

|     | INP | OUTPUTS  |   |                  |                  |
|-----|-----|----------|---|------------------|------------------|
| PRE | CLR | CLK      | D | Q                | Q                |
| L   | L   | X        | Х | H <sup>(1)</sup> | H <sup>(1)</sup> |
| Н   | Н   | <b>↑</b> | Н | Н                | L                |
| Н   | Н   | <b>↑</b> | L | L                | Н                |
| Н   | Н   | L        | X | $Q_0$            | $\overline{Q}_0$ |

<sup>(1)</sup> This configuration is unstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.

### 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

Toggle switches are typically large, mechanically complex and relatively expensive. It is desirable to use a momentary switch instead because they are small, mechanically simple and low cost. Some systems require a toggle switch's functionality but are space or cost constrained and must use a momentary switch instead.

If the data input (D) of the D-type flip-flop is tied to the inverted output  $(\overline{\mathbb{Q}})$ , then each clock pulse will cause the value at the output (Q) to toggle. The momentary switch can be debounced and connected through a Schmitt-trigger buffer to the clock input (CLK) to toggle the output.

This application also utilizes a power-on reset circuit so that the output always starts in the LOW state when power is applied.

### 8.2 Typical Application

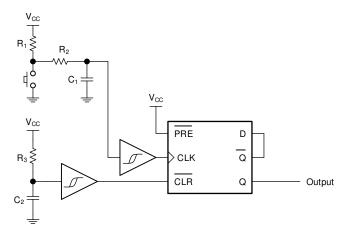


Figure 8-1. Typical Application Schematic

#### 8.2.1 Design Requirements

#### 8.2.1.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics - 74*.

The supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74AHC74Q-Q1 plus the maximum supply current,  $I_{CC}$ , listed in the *Electrical Characteristics - 74*. The logic device can only source or sink as much current as it is provided at the supply and ground pins, respectively. Be sure to not exceed the maximum total current through GND or  $V_{CC}$  listed in the *Absolute Maximum Ratings*.

Total power consumption can be calculated using the information provided in CMOS Power Consumption and  $C_{pd}$  Calculation.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear* and Logic (SLL) Packages and Devices.

Submit Document Feedback

Copyright © 2024 Texas Instruments Incorporated

#### **CAUTION**

The maximum junction temperature,  $T_J(max)$  listed in the *Absolute Maximum Ratings*, is an *additional limitation* to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

#### 8.2.1.2 Input Considerations

Unused inputs must be terminated to either  $V_{CC}$  or ground. These can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input is to be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The resistor size is limited by drive current of the controller, leakage current into the SN74AHC74Q-Q1, as specified in the *Electrical Characteristics - 74*, and the desired input transition rate. A 10-k $\Omega$  resistor value is often used due to these factors.

The SN74AHC74Q-Q1 has standard CMOS inputs, so input signal edge rates cannot be slow. Slow input edge rates can cause oscillations and damaging shoot-through current. The recommended rates are defined in the Recommended Operating Conditions.

Refer to the Feature Description for additional information regarding the inputs for this device.

#### 8.2.1.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the  $V_{OH}$  specification in the *Electrical Characteristics - 74*. Similarly, the ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the  $V_{OL}$  specification in the *Electrical Characteristics - 74*.

Unused outputs can be left floating. Do not connect outputs directly to V<sub>CC</sub> or ground.

Refer to Feature Description for additional information regarding the outputs for this device.

#### 8.2.1.4 Timing Considerations

The SN74AHC74Q-Q1 is a clocked device. As such, it requires special timing considerations for normal operation.

Primary timing factors to consider:

- Maximum clock frequency: the maximum operating clock frequency defined in *Timing Requirements 74* is the maximum frequency at which the device is designed to function. This value refers specifically to the triggering waveform, measuring from one trigger level to the next.
- Pulse duration: ensure that the triggering event duration is larger than the minimum pulse duration, as defined in the *Timing Requirements 74*.
- Setup time: ensure that the data has changed at least one setup time prior to the triggering event, as defined in the *Timing Requirements 74*.
- Hold time: ensure that the data remains in the desired state at least one hold time after the triggering event, as defined in the *Timing Requirements 74*.

#### 8.2.2 Detailed Design Procedure

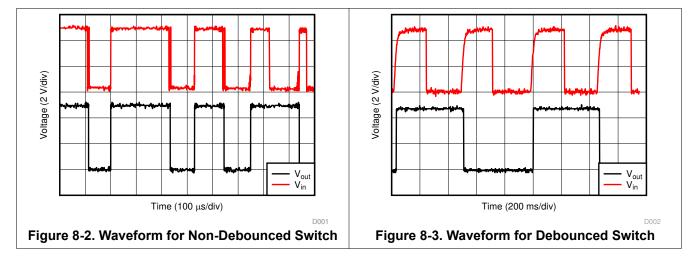
- Add a decoupling capacitor from V<sub>CC</sub> to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V<sub>CC</sub> and GND pins. An example layout is shown in the *Layout Example*.
- Ensure the capacitive load at the output is ≤ 70 pF. This is not a hard limit; however, it will
  optimize performance. This can be accomplished by providing short, appropriately sized traces from the
  SN74AHC74Q-Q1 to the receiving device.
- 3. Ensure the resistive load at the output is larger than  $(V_{CC} / I_O(max)) \Omega$ , so that the maximum output current from the *Absolute Maximum Ratings* is not violated. Most CMOS inputs have a resistive load measured in mega ohms; much larger than the minimum calculated above.

Copyright © 2024 Texas Instruments Incorporated

Submit Document Feedback

4. Thermal issues are rarely a concern for logic gates, however the power consumption and thermal increase can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation* 

### 8.2.3 Application Curves



### 8.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the *Layout Example*.

#### 8.4 Layout

#### 8.4.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.



### 8.4.2 Layout Example

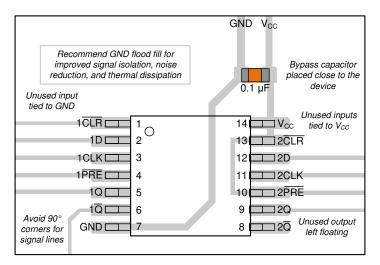


Figure 8-4. Example Layout for the SN74AHC74Q-Q1



### 9 Device and Documentation Support

### 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, CMOS Power Consumption and Cpd Calculation
- Texas Instruments, Implications of Slow or Floating CMOS Inputs
- Texas Instruments, Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices

### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on Notifications to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 9.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 9.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 9.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

#### 10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

# Changes from Revision C (October 2023) to Revision D (February 2024) **Page**

# Changes from Revision B (August 2023) to Revision C (October 2023) Updated RθJA values: PW = 113 to 147.7, all values in °C/W .......5

# 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN74AHC74Q-Q1

www.ti.com 1-Nov-2025

#### PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins  | Package qty   Carrier | RoHS | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|-----------------|-----------------------|------|-------------------------------|----------------------------|--------------|--------------|
|                       | (1)    | (2)           |                 |                       | (3)  | (4)                           | (5)                        |              | (6)          |
| SN74AHC74QDRG4Q1      | Active | Production    | SOIC (D)   14   | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |
| SN74AHC74QDRG4Q1.A    | Active | Production    | SOIC (D)   14   | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |
| SN74AHC74QDRQ1        | Active | Production    | SOIC (D)   14   | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |
| SN74AHC74QDRQ1.A      | Active | Production    | SOIC (D)   14   | 2500   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |
| SN74AHC74QPWRG4Q1     | Active | Production    | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | HA74Q        |
| SN74AHC74QPWRG4Q1.A   | Active | Production    | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | HA74Q        |
| SN74AHC74QPWRG4Q1.B   | Active | Production    | TSSOP (PW)   14 | 2000   LARGE T&R      | -    | Call TI                       | Call TI                    | -40 to 125   |              |
| SN74AHC74QPWRQ1       | Active | Production    | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | HA74Q        |
| SN74AHC74QPWRQ1.A     | Active | Production    | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-3-260C-168 HR        | -40 to 125   | HA74Q        |
| SN74AHC74QWBQARQ1     | Active | Production    | WQFN (BQA)   14 | 3000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |
| SN74AHC74QWBQARQ1.A   | Active | Production    | WQFN (BQA)   14 | 3000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 125   | AHC74Q       |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



## **PACKAGE OPTION ADDENDUM**

www.ti.com 1-Nov-2025

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

www.ti.com 24-Jul-2025

### TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device            | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|-------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74AHC74QDRQ1    | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| SN74AHC74QPWRG4Q1 | TSSOP           | PW                 | 14 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |
| SN74AHC74QPWRG4Q1 | TSSOP           | PW                 | 14 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |
| SN74AHC74QPWRQ1   | TSSOP           | PW                 | 14 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |
| SN74AHC74QPWRQ1   | TSSOP           | PW                 | 14 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |
| SN74AHC74QWBQARQ1 | WQFN            | BQA                | 14 | 3000 | 180.0                    | 12.4                     | 2.8        | 3.3        | 1.1        | 4.0        | 12.0      | Q1               |



www.ti.com 24-Jul-2025



\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74AHC74QDRQ1    | SOIC         | D               | 14   | 2500 | 353.0       | 353.0      | 32.0        |
| SN74AHC74QPWRG4Q1 | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| SN74AHC74QPWRG4Q1 | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| SN74AHC74QPWRQ1   | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| SN74AHC74QPWRQ1   | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| SN74AHC74QWBQARQ1 | WQFN         | BQA             | 14   | 3000 | 210.0       | 185.0      | 35.0        |



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



2.5 x 3, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



www.ti.com



PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

<sup>6.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025